

## TEST REPORT EN 60947-2

## Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

Report Number. ...... 03601-A-19D0075-S

Date of issue .....: 2019-10-15

Total number of pages...... 399

Name of Testing Laboratory Suzhou Electrical Apparatus Science Research Institute Co., Ltd.

preparing the Report..... (EETI)

Address ......: Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang

Province, P.R.China

Test specification:

Standard..... EN 60947-2:2017

Test procedure .....: CCA

Non-standard test method .....: N/A

Test Report Form No. ..... EN 60947\_2H

Test Report Form(s) Originator ....: DEKRA Certification B.V.

Master TRF...... Dated 2017-04

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Test item description .....: Circuit-breaker Incorporating Residual Current Protective

Trade Mark .....: TENGEN

Manufacturer...... : Zhejiang Tengen Electric Co., Ltd.

Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang

Province, P.R.China

Model/Type reference ...... TGM...-125,TGM...-160

Ratings ...... See page 12

Res	ponsible Testing Laboratory (as applicab	ble), testing procedure and testing location(s):
	Testing Laboratory:	Suzhou Electrical Apparatus Science Research Institu
Tes	ting location/ address:	No.7 Yonghe Street, Binhe Road, New District, Suzhi China
Tested by (name, function, signature):		(Todit Today)
App	proved by (name, function, signature):	Chen Yuan (Supervisor)
	Testing procedure: CTF Stage 1:	
Tes	ting location/ address:	
Tes	ted by (name, function, signature):	
App	roved by (name, function, signature):	
	Testing procedure: CTF Stage 2:	
Tes	ting location/ address	
Tes	ted by (name + signature)	
Wit	nessed by (name, function, signature)	:
App	proved by (name, function, signature)	:
	Testing procedure: CTF Stage 3:	
	Testing procedure: CTF Stage 4:	
Tes	ting location/ address	.:
Tes	ted by (name, function, signature):	
Wit	nessed by (name, function, signature).	
	proved by (name, function, signature)	
Supervised by (name, function, signature)		